

Journal of Research of the

National Institute of Standards and Technology





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- High Performance Systems and Services
- Distributed Computing and Information Services
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¹At Boulder, CO 80303.

²Some elements at Boulder, CO.

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Contents

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Articlos

Thermal Conductivity of Magnesium Oxide From Absolute, Steady-State Measurements	A. J. Slifka, B. J. Filla, and J. M. Phelps	357
Comparison of the NIST and ENEA Air Kerma Standards	R. F. Laitano, P. J. Lamperti, and M. P. Toni	365
Liquidus Diagram of the Ba-Y-Cu-O System in the Vicinity of the Ba ₂ YCu ₃ O _{6+x} Phase Field	Winnie Wong-Ng and Lawrence P. Cook	379
The Refinement-Tree Partition for Parallel Solution of Partial Differential Equations	William F. Mitchell	405
	William F. Mitchell Barbara J. Belzer and James R. Ehrstein	405
Partial Differential Equations Conference Reports	Barbara J. Belzer and	

GENERAL DEVELOPMENTS	429
Thirty-Six Companies Apply for 1998 Baldrige Award NIST Training on Price Scanning Accuracy Benefits Consumers Industry, Government Team Up for Seamless, Secure E-Commerce	
Researchers Find Cool Way to Make Laser Measurements Round Is More Sound for UV Weathering of Materials	430
Traveling Kits Make Scattering Parameter Traceability Easier Fall Workshop Features State of the Art in Oil Spill Burning NIST Machine to Aid in Making Better Artificial Joints	431

Volume 103, Number 4, July–August 1998 Journal of Research of the National Institute of Standards and Technology

Public Inquiries Number Now a Snap to Remember NIST Helps Insurers Evaluate Year 2000 Preparedness October Workshop to Write Next Chapter in Publishing	432
Partnership for Competent Lab Accreditation Now Incorporated Bipolar Voltage Source Developed for AC and DC Metrology NIST to STEP into New Role	433
Wanted: Baldrige Award Examiners for 1999 Keck Foundation to Fund Optical Lab at JILA Fact Sheet Highlights Progress on NSMP Projects	434
Proposals Sought for Precision Measurement Grants NIST Validates First FIPS 140-1 Level 3 Cryptographic Module	435
NIST Model Boosts CMM Accuracy Virtual Instrument Provides Low-Cost RF and Microwave Device Measurement Capability, Draws Software Requests NIST Studies Impacts of Residential Mechanical Ventilation Approaches	436
Method Developed for Simulating Thermal Magnetization Decay to Test Suitability of Materials for Magnetic Recording Media Reveals Errors in Conventional Measurements First Sputter Deposition Single-Crystal Nickel Films Grown on Oriented Diamond Surfaces Programmable Josephson Voltage Standard System Enhances Watt-Balance Experiment NIST Kicks-off Electronic Commerce Testbed for Electronics Manufacturing	437
Monte Carlo Calculations Successfully Predicted Ferroelectric Behavior Magnetic Behavior of Electrodeposited Cu-Co Multilayers	438
NIST Supports Development of a New Type of Hearing Aid Polarizing Neutrons with Polarized ³ He	439
New Technique for Detecting Chemical Weapons Scientific Applications Support Project Releases "AutoMap on the Web" Energy-Related Inventions Program Makes Recommendations	440
Direct Observation of In Situ Reaction Processes Using Synchrotron Radiation NIST Assists Development of Fire Investigation Educational Tool NIST Helps to Form Zeolite Study Association	441
NIST Collaborating with Navy and Industry on Producibility Handbook NIST Assists Federal Agencies with Guidance on Security Training NIST Research Reported at American Physical Society March Meeting	442
NIST Calibrates New System to Image Radioactive Contamination NIST Solves Measurement Discrepancy for Radiopharmaceutical NIST Finds That Flammable Refrigerants May Be the Answer	443

Volume 103, Number 4, July–August 1998 Journal of Research of the National Institute of Standards and Technology

NIST Announces WebMetrics 1.0	444	
Molecular-Level Details of a Self-Assembly Process		
X-Ray Crystal Structure of Biotechnology Enzyme		
An ISO Success Story		
Ultrafast True Temperature Measurements for Thermophysical Properties	445	
NIST's Asynchronous Transfer Mode (ATM) Simulator Widely Used		
for ATM Performance Analysis		
Transatlantic Initiative Provides Forum for International Manufacturing Alliances	446	
Lighting Consortium Meets at NIST		
New Refrigerant Measurement Technology		
NIST Assists Company in Development of Super Insulation		
Java Grande Forum Established		